Lecture 10: Protection & HTS Magnets

- Key magnet issues vs. $T_{op}$; Areas of failure in superconducting magnets
- Key problems: overheating; high voltage; overstressing; over pressure
- Protection against overheating: self-protecting magnets; normal zone propagation; active protection; detection of quench
- High voltage — driven mode & persistent mode; overstressing
- Over pressure—bath cooled & CICC
- HTS Magnets & Issues
- Bi-2223/Ag Data
- YBCO composite
- $J_c (B)$ data @ 4.2, 10, and 20 K of superconductors
- 1-D NZP of YBCO: Energy margin & NZP velocity (FSU/NHMFL)
- Stability experiment & simulation of YBCO at 77 K (MIT)
- 1-D NZP of YBCO: Energy margin & NZP velocity (ORNL)
Key Magnet Issues vs $T_{op}$

Cost or Difficulty

- Protection Conductor
- Mechanical
- Stability Cryogenics

$T_{op}$ [K]

LTS

HTS

Y. Iwasa (05/08/03)
Areas of Failure in Superconducting Magnets

In the order of decreasing reported incidents.

- Insulation
- Mechanical
- System performance
- Conductor
- External system
- Coolant
Key Quench-Induced Problems

- Overheating
- High voltage
- Overstressing
- Over pressure
Overheating

Energy Conversion

\[
\frac{B_0^2}{2\mu_0} = h_{cu}(T_m) - h_{cu}(T_{op}) = 5.2 \times 10^9 \text{ J/m}^3
\]

\[\uparrow \quad \uparrow \]

1356 K 4.2 K

\[B_0 = 115 \text{ T}\]

- For a uniform energy conversion over the entire winding, a quench-induced \( T_{max} \) will remain <100 K, an upper limit to keep the differential thermal expansion stresses negligible.
Protection Against Overheating

1. Self-Protecting Magnets

- Normal zone propagation speed, $U_{nzp}$, fast enough to spread normal zone over most of the winding volume from a localized “hot spot” initially created. Specifically, a self-protecting magnet must satisfy:

$$\tau_{dxy} \sim \frac{a_2 - a_1}{U_{nzp}}$$

- “Large” magnets are not self-protecting.
- $[U_{nzp}]_{HTS} \ll [U_{nzp}]_{LTS}$: HTS magnets not self-protecting.
An Example

- $B_0 = 8$ T
- $E_{mg} = 10^6$ J
- Winding volume = 0.06 m³ (~2 ft³)

<table>
<thead>
<tr>
<th>Winding % Absorbing $E_{mg}$</th>
<th>$T_f$ [K]</th>
<th>Remarks</th>
</tr>
</thead>
<tbody>
<tr>
<td>100</td>
<td>55</td>
<td>Well below 100 K</td>
</tr>
<tr>
<td>50</td>
<td>70</td>
<td>&lt; 100 K</td>
</tr>
<tr>
<td>10</td>
<td>130</td>
<td>Barely acceptable</td>
</tr>
<tr>
<td>1</td>
<td>580</td>
<td>Unacceptable</td>
</tr>
</tbody>
</table>
Normal Zone Propagation Velocity

Along Wire Axis--No Matrix

\[ C_n \frac{\partial T_n}{\partial t} = \frac{\partial}{\partial z} \left( k_n \frac{\partial T_n}{\partial z} \right) + \rho_n J^2 \]  
(normal state)

\[ C_s \frac{\partial T_s}{\partial t} = \frac{\partial}{\partial z} \left( k_s \frac{\partial T_s}{\partial z} \right) \]  
(Superconducting state)

\[ \frac{\partial T}{\partial t} = \frac{\partial T}{\partial z} \frac{\partial z}{\partial t} = -U_\ell \frac{\partial T}{\partial z} \]  
\( (U_\ell: \text{longitudinal velocity}) \)
\[-C_n U_\ell \frac{dT_n}{dz} = \frac{d}{dz} \left( k_n \frac{dT_n}{dz} \right) + \rho_n J^2 \]

\[-C_s U_\ell \frac{dT_s}{dz} = \frac{d}{dz} \left( k_s \frac{dT_s}{dz} \right) \]

Assume \( k_n, k_s, \) and \( \frac{d^2 T_n}{dz^2} \equiv 0 \) near \( z = 0 \)

\[C_n U_\ell \frac{d T_n}{dt} + \rho_n J^2 = 0 \quad (z < 0) \]

\[k_s \frac{d^2 T_s}{dz^2} + C_s U_\ell \frac{dT_s}{dt} = 0 \quad (\xi > 0) \]

\[T_s (z) = Ae^{-cz} + T_{op} \quad C = \frac{C_s U_\ell}{k_s} \]
At $z = 0$ \( T_s (0) = T_c \)

\[
T_s (z) = (T_c - T_p) e^{-(C_s U_{\ell} / k) z} + T_{op}
\]

At $z = 0$ \( k_n (dT_n/dz) = k_s (dT_s/dz) \)

\[
- \frac{k_n \rho_n J^2}{C_n U_{\ell}} = -C_s U_{\ell} (T_c - T_{op})
\]

\[
U_{\ell} = J \sqrt{\frac{\rho_n k_n}{C_n C_s (T_c - T_{op})}}
\]
\[ C_s = C_n = C_0 \]

\[ U_\ell = \frac{J}{C_0} \sqrt{\frac{\rho_n k_n}{(T_c - T_{op})}} \]

- \( U_i \propto J \)
- \( U_i \propto 1/C_0 \Rightarrow [U_i]_{hts} \ll [U_i]_{lts} \)

In the presence of normal metal matrix:

\[ U_\ell = \frac{J_m}{C_{cd}} \sqrt{\frac{\rho_m k_m}{(T_{cs} - T_{op})}} \]

Note that \( T_{cs} = T_t \)
With $C_n(T), C_s(T), k_n(T)$:

$$U = J \sqrt{\frac{\rho_n(T_{cs})k_n(T_{cs})}{C_n(T_{cs}) - \frac{1}{k_n(T_{cs})} \frac{d k_n(T)}{dT}}} \left| \int_{T_{cs}}^{T_{op}} C_s(T) dT \right| \int_{T_{op}}^{T_{cs}} C_s(T) dT$$

Note that $T_{cs} = T_t$
1-D “Adiabatic” NZP—Experimental & Simulation Results


Y. Iwasa (05/08/03)
Nb$_3$Sn Tape @ 12 K & 225 A

$U_i = 50$ cm/s

Temperature Simulation

Simulation

$V_1$, $V_2$, $V_3$, $V_4$

Y. Iwasa (05/08/03)
Bi-2223/Ag Tape @ 14 K & 100 A

\[ [U_l]_{hts} = 1 \text{ cm/s} \ll [U_l]_{lts} \]

Temperature Simulation

- 60 s
- 10 s

- \( T_c = 93 \text{ K} \)
- \( T_{cs} = 44.4 \text{ K} \)
2. Active Protection

“Detect-and-Dump”

- Widely used in large magnets.
- Dissipates most of the stored magnet energy into a “dump resistor” connected across the magnet terminals.
- A “hot spot” heated only over a “brief” period of current decay.
- Leads to another criterion for operating current density.
\[ L_{mg} \frac{dI(t)}{dt} + [r(t) + R_D]I(t) = 0 \]

For \( r(t) \ll R_D \):

\[ L_{mg} \frac{dI(t)}{dt} + R_D I(t) = 0 \quad \Rightarrow \quad I(t) = I_\phi \exp \left( -\frac{R_D t}{L_{mg}} \right) \quad \Rightarrow \quad J_m(t) = [J_{op}]_m \exp \left( -\frac{R_D t}{L_{mg}} \right) \]

With \( g_k = g_d = g_q = 0 \):

\[ A_{cd} C_{cd}(T) \frac{dT}{dt} = \frac{\rho_m(T)}{A_m} I^2(t) \quad \Rightarrow \quad C_c(T) \frac{dT}{dt} = \rho_m(T) \left( \frac{A_m}{A_{cd}} \right) J_m^2(t) \]

\[ \frac{C_{cd}(T)}{\rho_m(T)} \frac{dT}{dt} = \left( \frac{A_m}{A_{cd}} \right) [J_\phi]_m^2 \exp \left( -\frac{2R_D t}{L_{mg}} \right) dt \]

\[ \int_{T_i}^{T_f} \frac{C_{cd}(T)}{\rho_m(T)} dT = Z(T_i, T_f) \geq \left( \frac{A_m}{A_{cd}} \right) [J_\phi]_m^2 \int_0^\infty \exp \left( -\frac{2R_D t}{L_{mg}} \right) dt = \left( \frac{A_m}{A_{cd}} \right) [J_{op}]_m^2 \frac{L_{mg}}{2R_D} \]

\[ Z(T_i, T_f) \geq \left( \frac{A_m}{A_{cd}} \right) [J_{op}]_m^2 \frac{L_{mg}}{2R_D} = \left( \frac{A_m}{A_{cd}} \right) [J_\phi]_m^2 \frac{2E_{mg}}{2V_D/I_\phi} = \left( \frac{A_m}{A_{cd}} \right) [J_{op}]_m^2 \frac{E_{mg}}{V_D I_\phi} \]

Y. Iwasa (05/08/03)
\[ Z(T_i, T_f) \equiv \int_{T_i}^{T_f} \frac{C_{cd}(T)}{\rho_m(T)} \, dT \]
\(Z(T)\) Functions:

1: Ag (99.99%)
2: Cu (RRR 200)
3: Cu (RRR 100)
4: Cu (RRR 50)
5: Al (99.99%)
“Protection” Criterion

\[ [J_{op}]_m \leq \sqrt{\left( \frac{A_{cd}}{A_m} \right) \frac{V_D I_{op} Z(T_i, T_f)}{E_{mg}}} \]

“Cryostable” Criterion

\[ [J_{op}]_{cd} \leq \sqrt{\frac{f_p P_{cd} A_m q_{fm}}{\rho_m (A_s + A_m)^2}} \]
Detect-and Dump : Options to improve \([J_{op}]_m\)

1. Increase \(I_{op}\)
   - Larger conductor; more expensive for given kA-m
   - Larger current leads--greater heat input
   - Larger \((I \times B)\) force
   - For a given power rating \(VI\), higher \(I\) more expensive

2. Increase \(V_D\)
   - Increased danger of voltage breakdown, particularly > 800 V in helium environment

3. Increase \(Z(T_f)\)
   - Better to keep \(T_f\) below ~100 K-150 K
   - Cu better than Al

4. Reduce \(E_{mg}\)
   - Subdivision—common practice with HEP & Fusion magnets
Detection of Non-Recovering Quench

\[ V_1(t) = L_1 \frac{dI(t)}{dt} + r(t)I(t) \quad V_2(t) = L_2 \frac{dI(t)}{dt} \]

\[ V_{at}(t) = V_2(t) - V_1(t) \]

\[ R_2 L_1 = R_1 L_2 \quad \Rightarrow \quad V_{out}(t) = -\left( \frac{R_2}{R_1 + R_2} \right) r(t)I(t) \]
High Voltage

- Driven mode magnet, i.e., operated with its power supply generally connected, except during a dump.
  - High voltage, i.e., $V_D$, appears across the magnet terminals.
- Persistent mode magnet, i.e., operated with its power supply removed, except when the magnet is being charged.
  - Terminal voltage is zero; high internal voltage may be induced.
Persistent Mode Operation

Operation Steps

1. With persistent switch (PS) resistive (heater on), energize the magnet.
2. Turn off the heater; PS becomes superconducting; slowly bring the supply current back to zero.
3. Disconnect the current leads from the magnet terminals.
4. Magnet now operates in “persistent mode.”
Persistent Mode Operation (Continued)

$r(t)$ represents:

1. quench-induced *variable* resistance; may lead to a high internal voltage *OR*
2. “small” *constant* resistance by imperfect splices; causes a “slow” field decay (time constant=${L_{mg}}/{r}$) in NMR & MRI magnets:

$$B(t) = B_0 e^{-(r/mg)t} = B_0 \left(1 - \frac{r}{L_{mg}} t \right) \quad \text{(for } L_{mg}/r << 1 \text{ hr})$$
Internal Voltage In Persistent Mode Magnet

- No internal voltage in a uniformly (100%) resistive magnet.
- Internal voltage in a partially resistive magnet.
- Large voltages can occur when a resistive zone confined to a small section.

No internal voltage
Internal Voltage in Persistent Mode

Y. Iwasa (05/08/03)
For $R_D >> r(t)$, internal voltage is essentially due to the inductive voltage. The maximum inductive occurs at $t = 0$ and it is equal $V_D$.

$\text{Effect of } r(t) \text{ is neglected.}$
Overstressing

- Overstressing generally occurs in a multi-coil system.
  - A quench in one coil increases the current in the rest of the coils—this is good for PROTECTION, because this increased current accelerates spreading of normal zones in the rest of the coils by inducing quenches in these coils.
  - This increased current may also cause overstressing in these coils.
Overstressing (\& Protection)

Example: 2-Coil System

A quench in Coil 1 induces an extra current in Coil 2.

1. Helps spreading out normal zone faster and over a large volume.
2. May overstress Coil 2

\[ I(t) \]

\begin{align*}
I_1 & \quad I_2 \\
\text{Overstress limit} & \\
\end{align*}

\[ t \]
Protection Circuit for an NMR Magnet

Y. Iwasa (05/08/03)
**Over Pressure**

- In every superconducting magnet system, driven, persistent, in which coolant is cryogen (helium, nitrogen), a quench generally causes generation of vapor within the cryostat, raising the cryostat pressure above a safe limit (no greater than ~ 1/3 atm).
  - Cryostat must be equipped with a relief valve or a “burst” disk to permit a rapid release of the vapor from the cryostat.
- For CICC there is another problem of having to estimate the internal pressure generated in CICC.
  - Conduit thickness and vent line diameter must be sized according to the maximum quench-induced internal pressure.
HTS Magnets & Issues

**HTS:** YBCO; BSCCO; MgB$_2$

**LTS:** Nb-Ti; Nb$_3$Sn

Magnet Grade Conductors:
- NbTi; Nb$_3$Sn; BSCCO 2223

![Graph showing the relationship between \(\mu_0 H_{c2}\) and temperature (T) for different HTS and LTS magnets.](https://example.com/graph.png)
**HTS**

- BSCCO 2223 currently available as “magnet grade conductor.”
  - Powder in Ag tube
- BSCCO 2212 being developed but not easily available.
- YBCO, compared with BSCCO, regarded more promising for electric power devices.
- MgB2 also regarded promising, because of its low cost.
**Bi-2223 High Current Density Wire: Non-Reinforced**

- **Thickness (avg):** 0.21 (+/-0.02mm)
- **Width (avg):** 4.1 (+/- 0.2mm)
- **Min. Critical Stress:** 75 MPa
- **Min. Critical Strain:** 0.15%
- **Min. Bend Dia:** 100 mm

**Variable Specifications:**
- **Min. \( I_c \):** 115 A—135 A
- **Piece Length:** 100 m—200 m

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**Slides 35-39: Based on American Superconductor Corp. Data Sheets**

Y. Iwasa (05/08/03)
**Bi-2223 High Strength Reinforced Tape**

**Stainless Steel Strips**

- Thickness (avg): 0.31 (+/-0.02mm)
- Width (avg): 4.1 (+/- 0.2mm)
- Min. Critical Stress: 265 MPa
- Min. Critical Strain: 0.4%
- Min. Bend Dia: 70 mm

**Variable Specifications:**
- Min. $I_c$: 115 A—135 A
- Piece Length: 100 m —300 m

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[Graph showing $I_c/I_c(0)$ vs Strain and Stress at 77K (MPa)]
Scaling Ratio to 77K (self-field) in // External Field

![Graph showing scaling ratio to 77K in parallel magnetic field (Tesla)].

- **Y. Iwasa (05/08/03)**

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**Scaling Ratio, \( I_c(T,B) / I_c(77K,0) \) as a function of Parallel Magnetic Field (Tesla).**
Scaling Ratio to 77K (self-field) in \perp External Field

![Graph showing the scaling ratio to 77K in a perpendicular external field for different temperatures (20K, 35K, 50K). The graph plots the scaling ratio against the perpendicular magnetic field (in Tesla).]
Scaling Ratio, 77K to 4.2K

![Graph showing scaling ratio between 77K and 4.2K magnetic field values.](image-url)
1-D NZP in YBCO Composite—Energy Margin & NZP Velocity

*set on buffer read for increased speed/resolution

Slides 45-51: Based on Justin Schwartz (DOE Meeting July 2002)

Y. Iwasa (05/08/03)
Bi2223 tape: Recovery

![Voltage vs. Time Graph]

- $V_1$
- $V_2$
- $V_3$

![Temperature vs. Time Graph]

- $C_1$
- $C_2$
**Bi-2223 High Current Density Wire: Non-Reinforced**

- Thickness (avg): 0.21 (+/- 0.02mm)
- Width (avg): 4.1 (+/- 0.2mm)
- Min. Critical Stress: 75 MPa
- Min. Critical Strain: 0.15%
- Min. Bend Dia: 100 mm

**Variable Specifications:**
- Min. $I_c$: 115 A—135 A
- Piece Length: 100 m — 200 m

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Slides 36-40: Based on American Superconductor Corp. Data Sheets

Y. Iwasa (05/08/03)
\[ I_{op} = 19 \text{ A;} \quad I_{c} = 22 \text{ A} \]
NZP @ 19 A & 80.6 K

![Graph showing voltage (V) vs. time (s) with markers for Primary Heater pulse and different voltage levels V1, V2, V3, V4 × 100]
Energy Margin vs. $I/I_c$ ($I_c = 22 \text{ A} @ 80.6 \text{ K}$)
NZP Velocity vs. $I/I_c$

Quench Propagation Velocity (cm/s) vs. $I/I_c$ (%)
Quench/Recovery
Experiment & Simulation

- Bath cooling @ 77K
- Forced-flow cooling @ 2-3 atm 80-81K
Forced Flow Experimental Setup

- Pressure Gauge
- Pressure Regulator
- Liquid Nitrogen
- Gas Tank
- Needle Valve
- Shut/Open Valve
- Volume Meter
- Shut/Open Valve
- Volume Meter
- Water
- Sample Holder
- 77K Hx
- RT Hx
- 77K Hx
- Sample Holder
- 77K (Styrofoam Bath)
- High-Pressure (3-atm) Section
NOTE: VERTICAL SCALE IS ≈ 10 TIMES ACTUAL;
HORIZONTAL SCALE ≈ ACTUAL
New Forced-Flow Sample Holder
Sample 2: \( V(I) \) Plot @77K \( [I_c=105\,\text{A}] \)

[Source-Measured \( I_c > 100\,\text{A} \)]
Sample 2: Forced-Flow (~81K; 5cm/s)
Sample 2: Forced-Flow (~81K; 3cm/s)
Sample 2: Forced-Flow (@81K)

![Graph showing voltage (V) over time (s) for two different flow rates: 170A/65A (3cm/s) and 170A/65A (5cm/s).]
Sample 2: Forced-Flow (5cm/s) & Bath

![Graph showing voltage (V) vs. time (s) for two conditions: 170A/71A (5cm/s) and 170A/75A (Bath).]
Simulation

\[ Q = h \Delta T_w = h A_s (T_w - T_f) \]

\[ h = \frac{k Nu}{D} \]

Re ≥ 3000, turbulent flow

\[ Nu = 0.023 \text{Re}^{0.8} \text{Pr}^{0.3} \]

Re < 3000, laminar flow

\[ Nu = 3.66 + \frac{0.0668(D/L)\text{Re} \text{Pr}}{1 + 0.04[(D/L)\text{Re} \text{Pr}]^{2/3}} \]

<table>
<thead>
<tr>
<th>T(K)</th>
<th>ρ(kg/m³)</th>
<th>Cp(j/kg K)</th>
<th>μ(μPa s)</th>
<th>κ(W/m K)</th>
</tr>
</thead>
<tbody>
<tr>
<td>83.0</td>
<td>779.9</td>
<td>2079</td>
<td>0.1228×10^{-3}</td>
<td>0.1247</td>
</tr>
<tr>
<td>84.0</td>
<td>8.628</td>
<td>1376</td>
<td>0.5791×10^{-5}</td>
<td>0.849×10^{-2}</td>
</tr>
</tbody>
</table>

Nitrogen Properties at 2 bar
(From Handbook of Cryogenic Engineering, I. G. WeisendII, 1998)
Sample 2: Bath @77 K & Simulation
Sample 2: Forced-Flow (3 cm/s) & Simulation

![Graph showing measurement and simulation data for forced-flow over time, with temperature and voltage measurements at different locations: entrance, middle, and exit. The graph includes data points for 65A, 45A, and 24A.]
Sample 2: Forced-Flow (5 cm/s) & Simulation
YBCO Samples in a Conduction Cooling Setup

- The sample was mounted between a Kapton-tape-insulated Cu-block and a G-10 block.
- It was affixed to the first-stage cold-head of a Cryomech GB-37 cryocooler for conduction cooling to about 40 K.
- A copper shield was added around the G-10 block to ensure a better uniform temperature of the tape.
- A heater was affixed to the copper base, and three PRT Thermometers are placed on the YBCO top surface.

Slides 69-78: Based on Winston Lue (ASC2002, August 2002)
**Over-Current Pulse Induced NZP**

- At each operating current, $I_{op}$ an initial over-current pulse was applied. The transient pulse energy was varied by changing the magnitude, $I_p$ or the duration of the pulse.

- The figures show at $T= 45$ K, and at an $I_{op}$ of 33.7-A and 2-s over-current pulse duration, an $I_p$ of 117.4 A caused a quench while 116.5 A did not.

- Distinctive normal zone propagation was observed when there was a quench.

- The inserts show the temperatures measured by a PRT at the center of the sample.
Stability Margins in the Range 45—80 K

- To measure the stability margin, the operating current was set near the lowest zone $I_c$ at a particular temperature.

- At the highest recovery pulse current, the $V$-$I$ product integrated over the initial pulse divided by the zone volume is used to estimate the stability margin.

- The measured stability margins ranged from 16 to 120 J/cm$^3$ as temperature lowers from 80 to 45 K.

- Comparison with the specific heat integrals indicated better fit to $T_c$ than to $T_{cs}$ for the HTS tapes.

- The higher margins measured at lower temperatures are attributed to the higher conduction cooling.

\[ T_{cs} = T_{op} + \left( T_c - T_{op} \right) \left( 1 - I_t / I_{cop} \right) \]
Minimum Propagation Currents

- At 45.4 K, the sample was subjected to an initial over-current pulse of 118 A for 2 s while increasing the operating propagation in 1 A steps.
- The figures show recovery at an operating current of 27.4 A and propagation at 28.4 A - a minimum propagation current.
- The initial heat input to zone 4 was about 4.6 J or 350.4 J/cm$^3$, about 3 times the stability margin.

$I_{op} = 27.4 \ A$

$I_{op} = 28.4 \ A$
Minimum Propagation Current vs. Temperature

- Minimum propagation currents were also determined by extrapolating the velocity versus current plots to zero velocity.
- Minimum propagation currents of 12 to 27 A were observed at 80.8 to 45.4 K.
- The existence of minimum propagation current is thought to be the result of conduction cooling.
NPZ always starts from the middle (zone 4) of this sample.

NZP velocities were found to be increasing linearly with the current.

No more than 20 mm/s of NZP velocity was measured when $I_{op}$ was set below $I_c$.

The outer zones which received better cooling resulted in lower NZP velocity and higher minimum propagation current.
• NZP velocities were measured at five different temperatures.

• NZP velocities at an operating current of 30.3 A were found at the different temperatures and plotted in the figure.

• NZP velocity vs. temperature shows a similar dependence as the ratio of operating to critical current.
Modified Adiabatic Theories of NZP Velocity

1. Constant material properties (Dresner)

\[ v_A = \frac{(I - I_{mp})}{A \cdot C_p} \sqrt{\frac{k\rho}{T_c - T_p}} \]

2. Variable material properties (Zhao and Iwasa)

\[ v_B = \frac{(I - I_{mp})}{A} \sqrt{\frac{k\rho \rho_n}{\int_{T_p}^{T_c} C_s dT \left( C_n + \frac{1}{k_n} \frac{dk_n}{dT} \int_{T_{op}}^{T_c} C_s dT \right)}} \]

3. Constant material properties with a different transition temperature (Bellis and Iwasa)

\[ v_C = \frac{(I - I_{mp})}{A} \sqrt{\frac{k\rho}{C_n C_s (T_t - T_p)}} \]

\[ T_t = T_{cs} + \frac{1}{2} (T_c - T_{cs}) \]
**NZP velocities: Experiment & Modified Adiabatic Theories**

- Inclusion of a minimum propagation current is necessary to achieve better agreement with the data.
- The agreement of the two Iwasa’s theories indicated the validity of a new transition point for HTS,
- Fair agreement is found between the data and the modified theory of Iwasa.
**ORNL Conclusion**

- Stability margins ranged from 16 to 120 J/cm$^3$ as temperature lowers from 80 to 45 K. Comparison with the specific heat integrals indicated better fit to $T_c$ than to $T_{cs}$ for the HTS tapes.
- Distinctive NZP in YBCO was observed at each of the measured temperatures.
- Minimum propagation current as a function of temperature was measured. Its existence is thought to be the result of conduction cooling.
- NZP velocities of no more than 20 mm/s were measured. Velocity vs. temperature data show a similar dependence as the ratio of operating to critical current and agrees with a modified adiabatic theory.